

Notice of Références Cited

Application/Control No.

09/828,575

Applicant(s)/Patent Under
Reexamination
SCHMIDT ET AL.

Examiner

Hae Moon Hyeon

Art Unit

2839

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	A	US-6371793	04-2002	Doorhy et al.	439/404
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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